

# Silicon Carbide (SiC) MOSFET - 20 mohm, 900 V, M2, TO-247-3L

### **NVHL020N090SC1**

#### **Features**

- Typ.  $R_{DS(on)} = 20 \text{ m}\Omega$  @  $V_{GS} = 15 \text{ V}$
- Typ.  $R_{DS(on)} = 16 \text{ m}\Omega$  @  $V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge (typ.  $Q_{G(tot)} = 196 \text{ nC}$ )
- Low Effective Output Capacitance (typ. Coss = 296 pF)
- 100% UIL Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

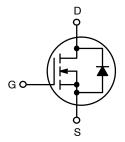
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	900	V
Gate-to-Source Voltag	ge		$V_{GS}$	+22/-8	V
Recommended Operativative Values of Gate-Source		T <sub>C</sub> < 175°C	$V_{GSop}$	+15/–5	٧
Continuous Drain Current $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	I <sub>DC</sub>	118	Α
Power Dissipation $R_{\theta JC}$			P <sub>DC</sub>	503	W
Continuous Drain Current $R_{\theta JC}$	Steady T <sub>C</sub> = 100°C State		I <sub>DC</sub>	83	Α
Power Dissipation $R_{\theta JC}$			P <sub>DC</sub>	251	W
Pulsed Drain Current (	Note 2)	T <sub>A</sub> = 25°C	I <sub>DM</sub>	472	Α
Single Pulse Surge Drain Current Capability(Note 3)	$T_A$ = 25°C, $t_p$ = 10 $\mu$ s, $R_G$ = 4.7 $\Omega$		I <sub>DSC</sub>	854	Α
Operating Junction and Range	Operating Junction and Storage Temperature Range			-55 to +175	°C
Source Current (Body Diode)			IS	153	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 23 A <sub>pk</sub> , L = 1 mH) (Note 4)			E <sub>AS</sub>	264	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Repetitive rating, limited by max junction temperature.
- 3. Peak current might be limited by transconductance.
- 4.  $E_{AS}$  of 264 mJ is based on starting  $T_J$  = 25°C; L = 1 mH,  $I_{AS}$  = 23 A,  $V_{DD}$  = 100 V,  $V_{GS}$  = 15 V.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
900 V	28 mΩ @ 15 V	118 A

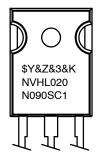


**N-CHANNEL MOSFET** 



TO-247 LONG LEADS CASE 340CX

#### MARKING DIAGRAM



\$Y = onsemi Logo &Z = Assembly Plant Code &3 = Date Code (Year & Week)

&K = Lot

NVHL020N090SC1 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping
NVHL020N090SC1	TO-247 Long Lead	30 Units / Tube

**Table 1. THERMAL CHARACTERISTICS** 

Parameter	Symbol	Мах	Units
Thermal Resistance Junction-to-Case (Note 1)	$R_{ heta JC}$	0.30	°C/W
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	40	°C/W

Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		900			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, refer to 25°C			500		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	Vpc - 900 V	T <sub>J</sub> = 25°C			100	μΑ
			T <sub>J</sub> = 175°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +22/-8 \text{ V}, \text{ V}$	<sub>DS</sub> = 0 V			±1	μΑ
ON CHARACTERISTICS	1			T			
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 2$	20 mA	1.8	2.7	4.3	V
Recommended Gate Voltage	$V_{GOP}$			-5		+15	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 15 \text{ V}, I_D = 6$			20	28	mΩ
		$V_{GS} = 18 \text{ V}, I_D = 6$			16		
		$V_{GS} = 15 \text{ V}, I_D = 6$	0 A, T <sub>J</sub> = 175°C		27		
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 60 A			49		S
CHARGES, CAPACITANCES & GATE RES	ISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 450 V			4415		pF
Output Capacitance	C <sub>OSS</sub>				296		-
Reverse Transfer Capacitance	C <sub>RSS</sub>				24		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/15 \text{ V}, V_{DS} = 720 \text{ V},$ $I_{D} = 60 \text{ A}$			196		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				42		1
Gate-to-Source Charge	$Q_{GS}$				78		
Gate-to-Drain Charge	$Q_{GD}$				55		
Gate-Resistance	$R_{G}$	f = 1 MHz			1.6		Ω
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/15 \text{ V}, V_{D}$			40		ns
Rise Time	t <sub>r</sub>	$I_D = 60 A, R_G = 2.$ Inductive Load	5 Ω,		63		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				55		1
Fall Time	t <sub>f</sub>				13		
Turn-On Switching Loss	E <sub>ON</sub>				2025		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>				201		
Total Switching Loss	E <sub>TOT</sub>	1			2226		1
DRAIN-SOURCE DIODE CHARACTERIST	1			1	1		l .
Continuous Drain-Source Diode Forward Current	I <sub>SD</sub>	$V_{GS} = -5 \text{ V}, T_{J} = 2$	25°C			153	А
Pulsed Drain-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> = 2	25°C			472	А
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = -5 V, I <sub>SD</sub> =	30 A, T <sub>,I</sub> = 25°C		3.8		V

Table 2. ELECTRICAL CHARACTERISTICS (T<sub>.J</sub> = 25°C unless otherwise stated)

Table 2. LLLOTHIOAL OTIATIAOTETIOTIOO (1J = 23 O utiliess stated)							
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS							
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/15 V, I <sub>SD</sub> = 60 A, dI <sub>S</sub> /dt = 1000 A/μs, V <sub>DS</sub> = 720 V		28		ns	
Reverse Recovery Charge	Q <sub>RR</sub>	αι <sub>S</sub> /αt = 1000 A/μs, ν <sub>DS</sub> = 720 ν		199		nC	
Reverse Recovery Energy	E <sub>REC</sub>			4		μJ	
Peak Reverse Recovery Current	I <sub>RRM</sub>			14		Α	
Charge Time	Ta			16		ns	
Discharge Time	Tb			12		ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

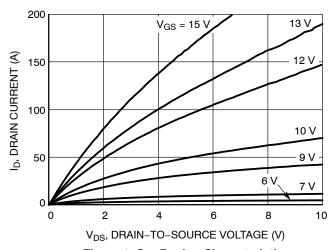


Figure 1. On-Region Characteristics

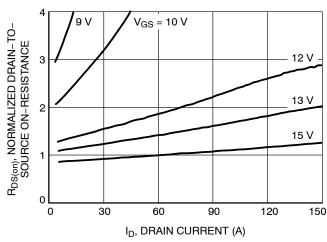


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

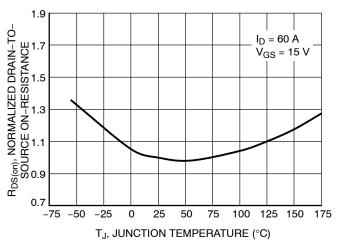


Figure 3. On–Resistance Variation with Temperature

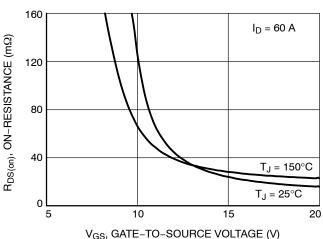


Figure 4. On-Resistance vs. Gate-to-Source Voltage

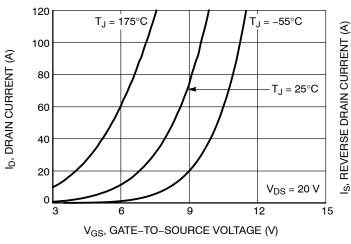


Figure 5. Transfer Characteristics

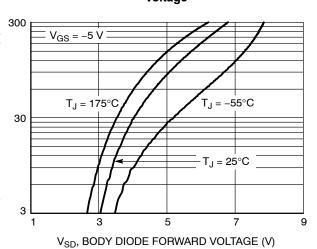


Figure 6. Diode Forward Voltage vs. Current

#### TYPICAL CHARACTERISTICS (continued)

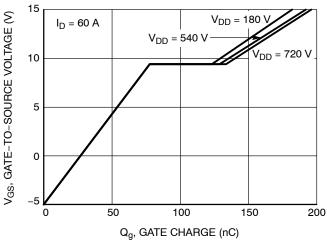


Figure 7. Gate-to-Source Voltage vs. Total Charge

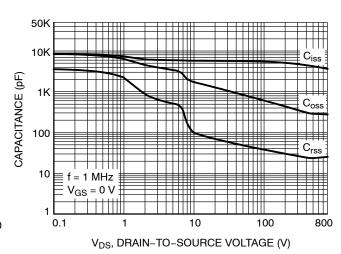


Figure 8. Capacitance vs. Drain-to-Source Voltage

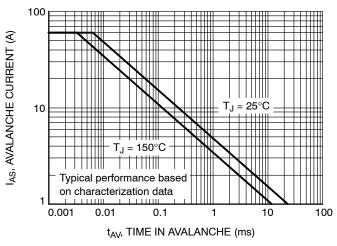


Figure 9. Unclamped Inductive Switching Capability

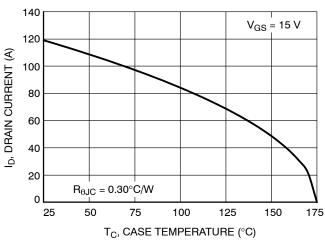


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

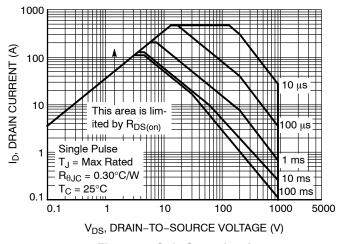


Figure 11. Safe Operating Area

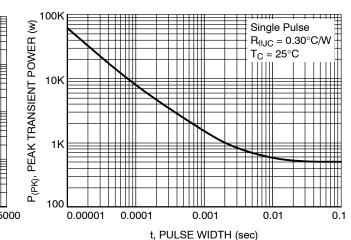


Figure 12. Single Pulse Maximum Power Dissipation

#### TYPICAL CHARACTERISTICS (continued)

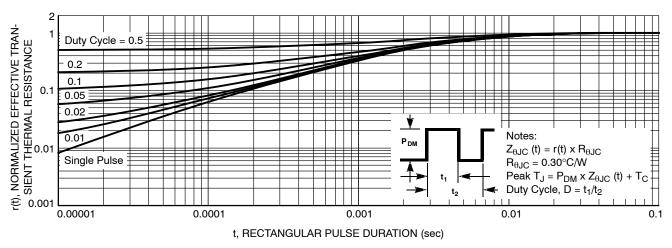
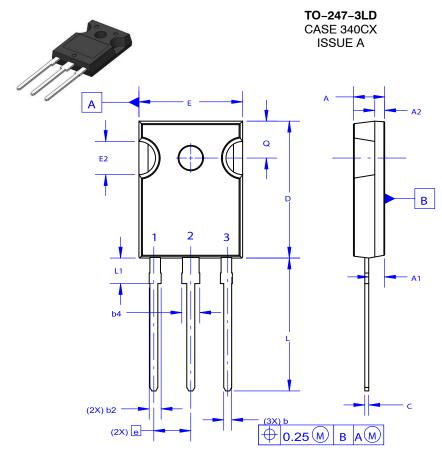


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

**DATE 06 JUL 2020** 





NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

## GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

Ø <sub>P</sub> —		Φ <sub>P1</sub> D2
E1 —	2	D1

DIM	MIL	LIMETER	S
DIM	MIN	NOM	MAX
Α	4.58	4.70	4.82
<b>A</b> 1	2.20	2.40	2.60
A2	1.40	1.50	1.60
D	20.32	20.57	20.82
Е	15.37	15.62	15.87
E2	4.96	5.08	5.20
е	~	5.56	~
L	19.75	20.00	20.25
L1	3.69	3.81	3.93
ØΡ	3.51	3.58	3.65
Q	5.34	5.46	5.58
S	5.34	5.46	5.58
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
С	0.51	0.61	0.71
D1	13.08	~	~
D2	0.51	0.93	1.35
E1	12.81	~	~
ØP1	6.60	6.80	7.00

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